

## FEATURES

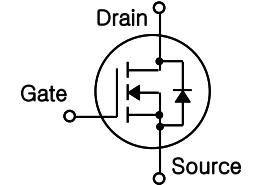
- ◆ Originative New Design
- ◆ 100% EAS Test
- ◆ Rugged Gate Oxide Technology
- ◆ Extremely Low Intrinsic Capacitances
- ◆ Remarkable Switching Characteristics
- ◆ Unequalled Gate Charge : 10.5 nC (Typ.)
- ◆ Extended Safe Operating Area
- ◆ Lower  $R_{DS(ON)}$  : 0.7 Ω (Typ.) @ $V_{GS}=10V$

## APPLICATION

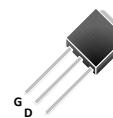
- ◆ Electronic lamp ballasts based on half bridge topology
- ◆ PFC (Power Factor Correction)
- ◆ SMPS (Switched Mode Power Supplies)

# **PFU6N40EG/PFD6N40EG** 400V N-Channel MOSFET

**BVDSS = 400 V**  
**RDS(ON) = 0.7 Ω**  
**ID = 4.8 A**



**I-PAK(TO-251)**



**D-PAK(TO-252)**



## Absolute Maximum Ratings

T<sub>C</sub>=25°C unless otherwise specified

Symbol	Parameter	Value	Units
V <sub>DSS</sub>	Drain-Source Voltage	400	V
I <sub>D</sub>	Drain Current – Continuous (T <sub>C</sub> = 25°C)	4.8	A
	Drain Current – Continuous (T <sub>C</sub> = 100°C)	3.1	A
I <sub>DM</sub>	Drain Current – Pulsed (Note 1)	19.3	A
V <sub>GS</sub>	Gate-Source Voltage	±30	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)	270	mJ
I <sub>AR</sub>	Avalanche Current (Note 1)	6.0	A
E <sub>AR</sub>	Repetitive Avalanche Energy (Note 1)	5.0	mJ
d <sub>v</sub> /dt	Peak Diode Recovery d <sub>v</sub> /dt (Note 3)	5.5	V/ns
P <sub>D</sub>	Power Dissipation (T <sub>C</sub> = 25°C)	50	W
	- Derate above 25°C	0.4	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range	-55 to +150	°C
T <sub>L</sub>	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	°C

## Thermal Resistance Characteristics

Symbol	Parameter	Typ.	Max.	Units
R <sub>θJC</sub>	Thermal Resistance, Junction-to-Case	--	2.5	°C/W
R <sub>θCS</sub>	Thermal Resistance, Case-to-Sink	--	50	
R <sub>θJA</sub>	Thermal Resistance, Junction-to-Ambient	--	110	

**Electrical Characteristics**  $T_c=25^\circ\text{C}$  unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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**On Characteristics**

$V_{GS(\text{TH})}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \mu\text{A}$	2.5	--	4.5	V
$R_{DS(\text{ON})}$	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}$ , $I_D = 3.0 \text{ A}$	--	0.7	0.95	$\Omega$

**Off Characteristics**

$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}$ , $I_D = 250 \mu\text{A}$	400	--	--	V
$\Delta BV_{DSS} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$ , Referenced to $25^\circ\text{C}$	--	0.4	--	$\text{V}/^\circ\text{C}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 400 \text{ V}$ , $V_{GS} = 0 \text{ V}$	--	--	1	$\mu\text{A}$
		$V_{DS} = 320 \text{ V}$ , $T_c = 125^\circ\text{C}$	--	--	10	$\mu\text{A}$
$I_{GSSF}$	Gate-Body Leakage Current, Forward	$V_{GS} = 30 \text{ V}$ , $V_{DS} = 0 \text{ V}$	--	--	100	nA
$I_{GSSR}$	Gate-Body Leakage Current, Reverse	$V_{GS} = -30 \text{ V}$ , $V_{DS} = 0 \text{ V}$	--	--	-100	nA

**Dynamic Characteristics**

$C_{iss}$	Input Capacitance	$V_{DS} = 25 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1.0 \text{ MHz}$	--	580	754	pF
$C_{oss}$	Output Capacitance		--	80	104	pF
$C_{rss}$	Reverse Transfer Capacitance		--	6	15	pF

**Switching Characteristics**

$t_{d(on)}$	Turn-On Time	$V_{DS} = 200 \text{ V}$ , $I_D = 6.0 \text{ A}$ , $R_G = 25 \Omega$	--	13.5	27	ns
$t_r$	Turn-On Rise Time		--	6.6	13	ns
$t_{d(off)}$	Turn-Off Delay Time		--	27	54	ns
$t_f$	Turn-Off Fall Time		--	5.5	11	ns
$Q_g$	Total Gate Charge	$V_{DS} = 320 \text{ V}$ , $I_D = 6.0 \text{ A}$ , $V_{GS} = 10 \text{ V}$	--	10.5	15	nC
$Q_{gs}$	Gate-Source Charge		--	3.5	--	nC
$Q_{gd}$	Gate-Drain Charge		--	3.9	--	nC

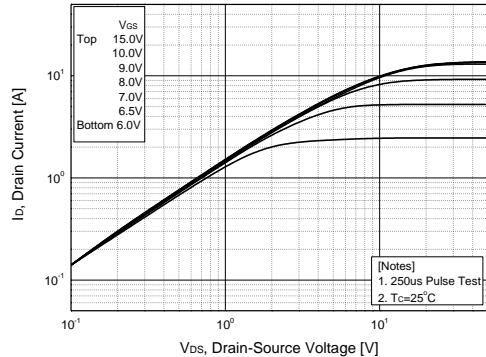
**Source-Drain Diode Maximum Ratings and Characteristics**

$I_s$	Continuous Source-Drain Diode Forward Current	--	--	6.0	A	
$I_{SM}$	Pulsed Source-Drain Diode Forward Current	--	--	24		
$V_{SD}$	Source-Drain Diode Forward Voltage	$I_s = 6.0 \text{ A}$ , $V_{GS} = 0 \text{ V}$	--	--	1.5	V
$t_{rr}$	Reverse Recovery Time	$I_s = 6.0 \text{ A}$ , $V_{GS} = 0 \text{ V}$	--	200	--	nS
$Q_{rr}$	Reverse Recovery Charge		$dI/dt = 100 \text{ A}/\mu\text{s}$ (Note 4)	--	1.1	$\mu\text{C}$

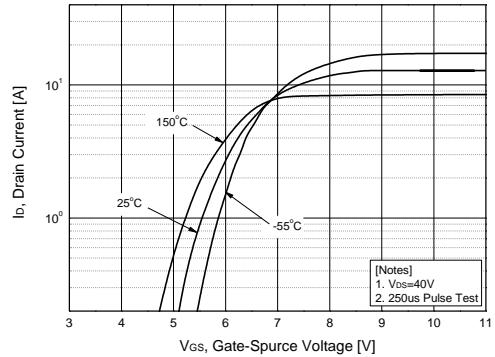
**Notes :**

- Repetitive Rating : Pulse width limited by maximum junction temperature
- $I_{AS}=6.0\text{A}$ ,  $V_{DD}=50\text{V}$ ,  $R_G=25\Omega$ , Starting  $T_J=25^\circ\text{C}$
- $I_{SD}\leq 6.0\text{A}$ ,  $di/dt\leq 300\text{A}/\mu\text{s}$ ,  $V_{DD}\leq BV_{DSS}$ , Starting  $T_J=25^\circ\text{C}$
- Pulse Test : Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$
- Essentially Independent of Operating Temperature

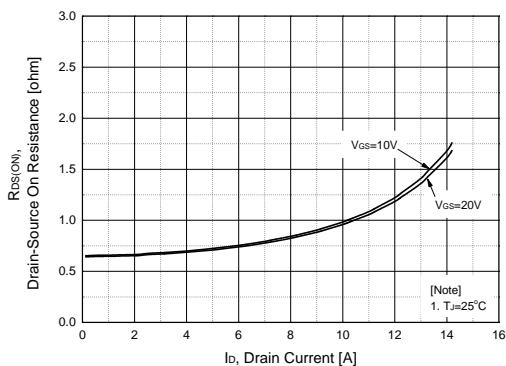
## Typical Characteristics



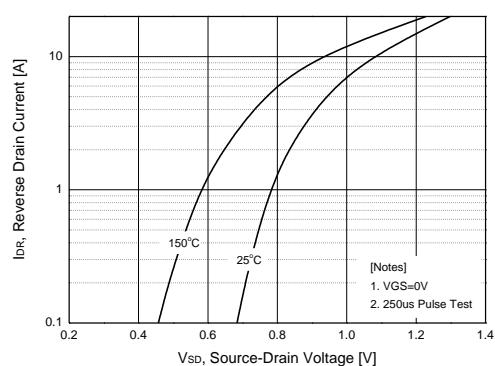
**Figure 1. On Region Characteristics**



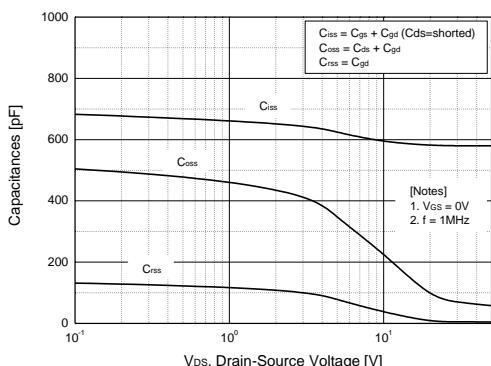
**Figure 2. Transfer Characteristics**



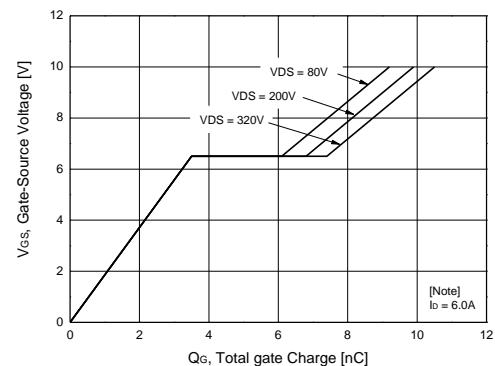
**Figure 3. On Resistance Variation vs. Drain Current and Gate Voltage**



**Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature**

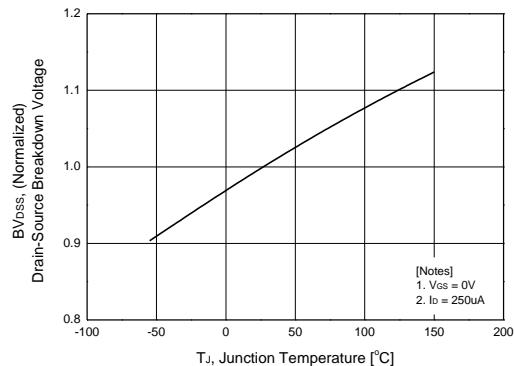


**Figure 5. Capacitance Characteristics**

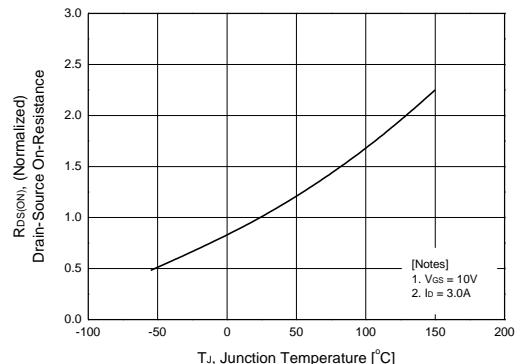


**Figure 6. Gate Charge Characteristics**

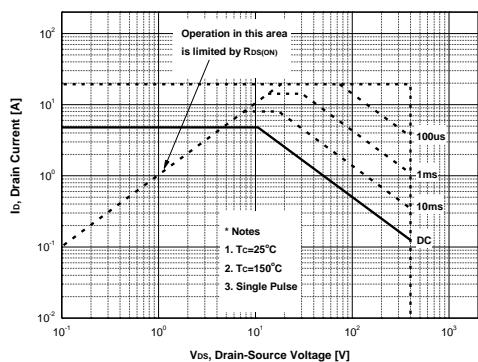
## Typical Characteristics (continued)



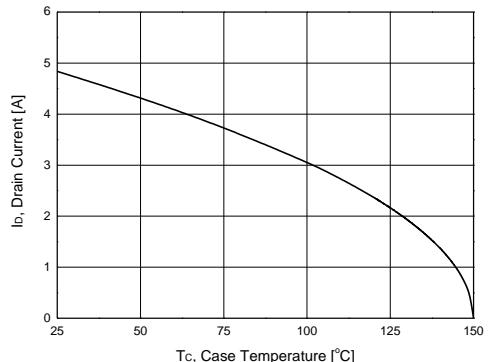
**Figure 7. Breakdown Voltage Variation vs Temperature**



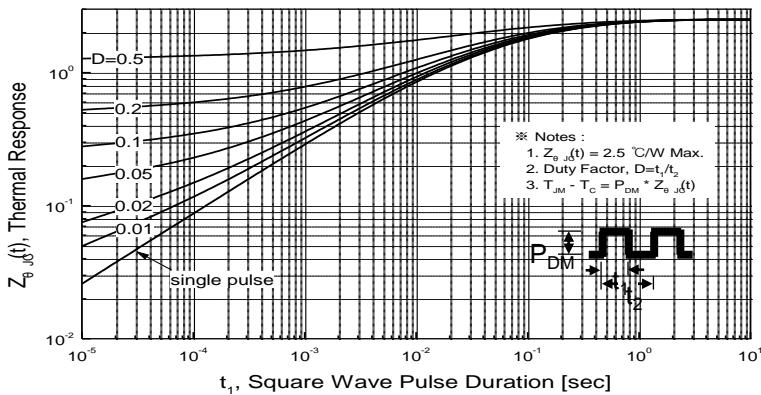
**Figure 8. On-Resistance Variation vs Temperature**



**Figure 9. Maximum Safe Operating Area**



**Figure 10. Maximum Drain Current vs Case Temperature**



**Figure 11. Transient Thermal Response Curve**

## Characteristics Test Circuit & Waveform

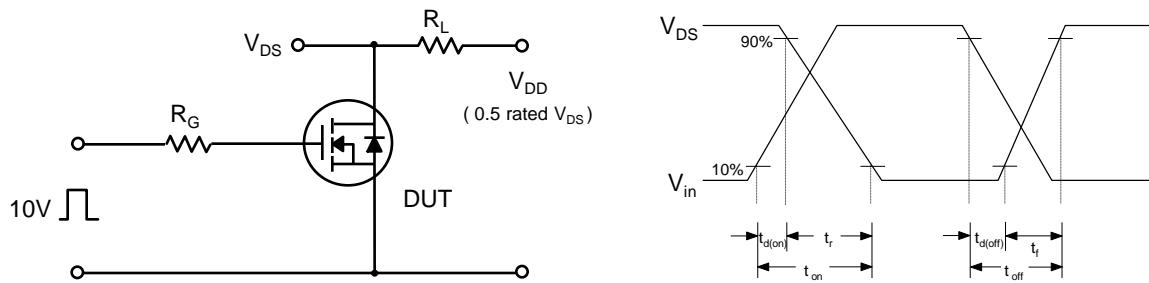


Fig 14. Resistive Switching Test Circuit & Waveforms

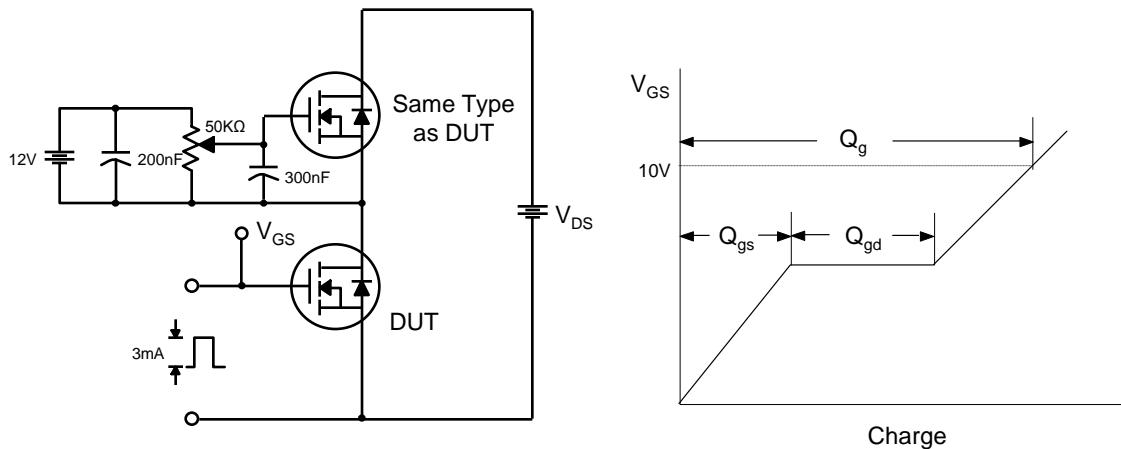


Fig 15. Gate Charge Test Circuit & Waveform

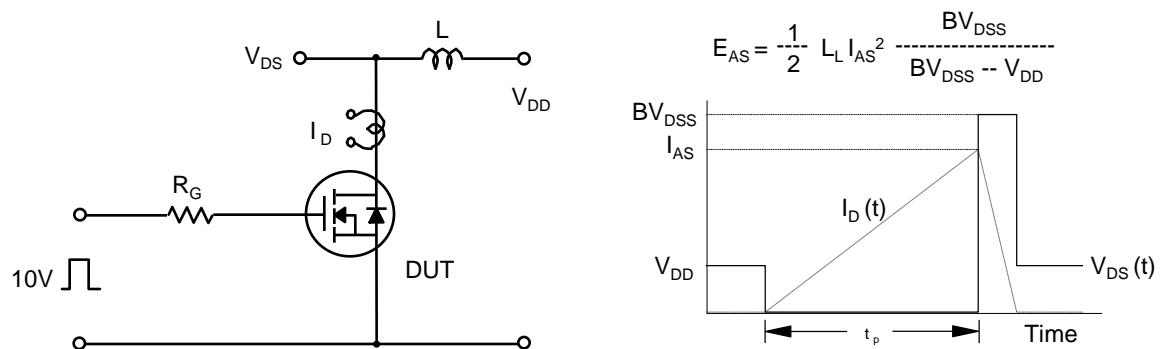


Fig 16. Unclamped Inductive Switching Test Circuit & Waveforms

## Characteristics Test Circuit & Waveform (continued)

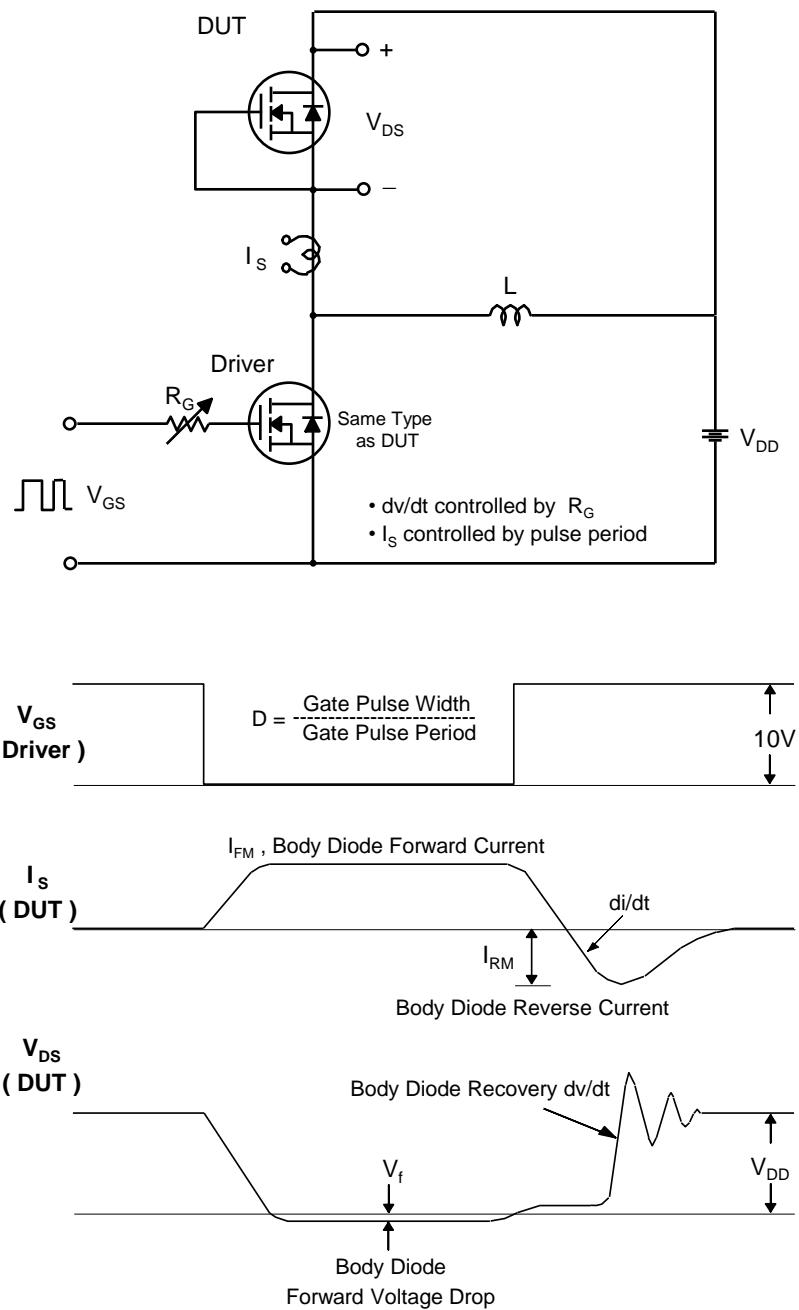
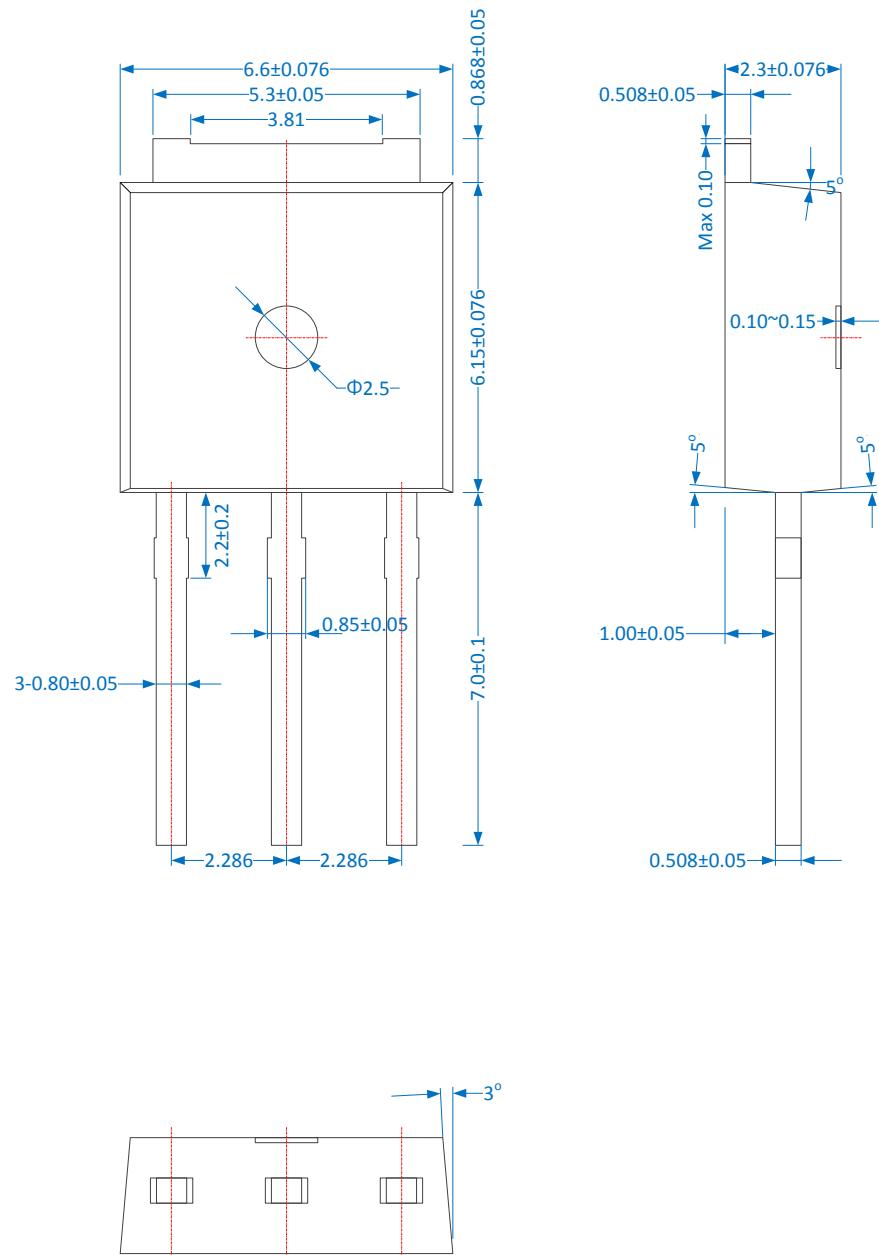


Fig 17. Peak Diode Recovery  $dv/dt$  Test Circuit & Waveforms

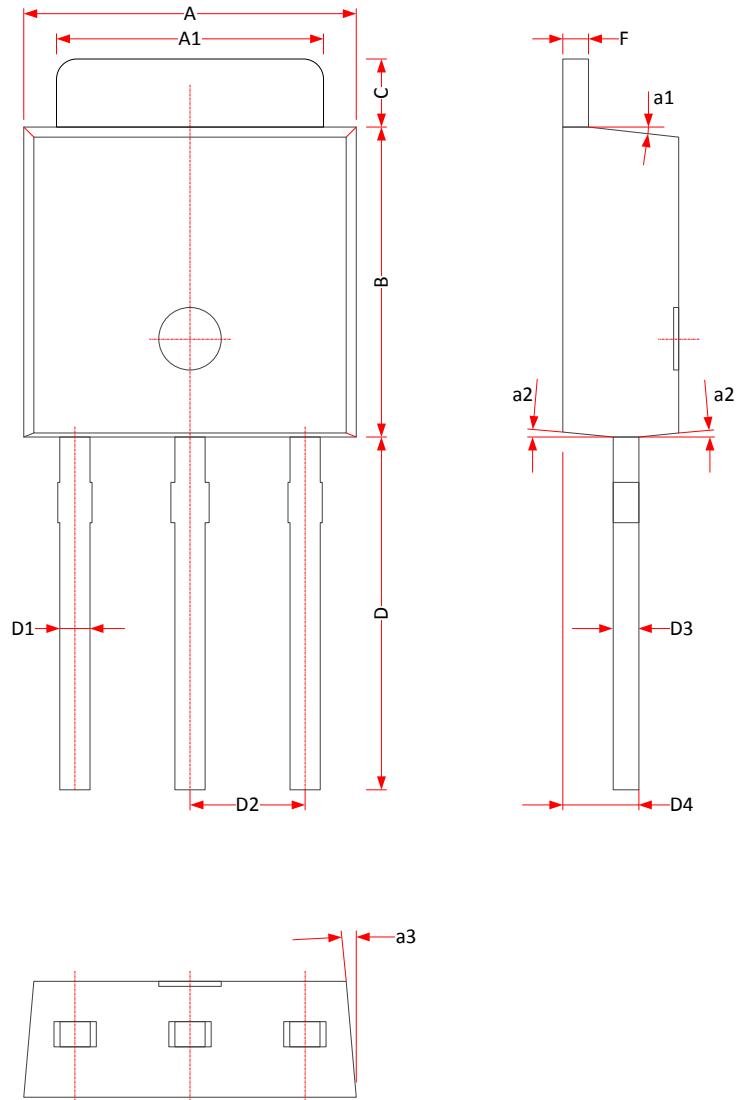
## Package Dimension

### I-PAK(TO-251) (Z)



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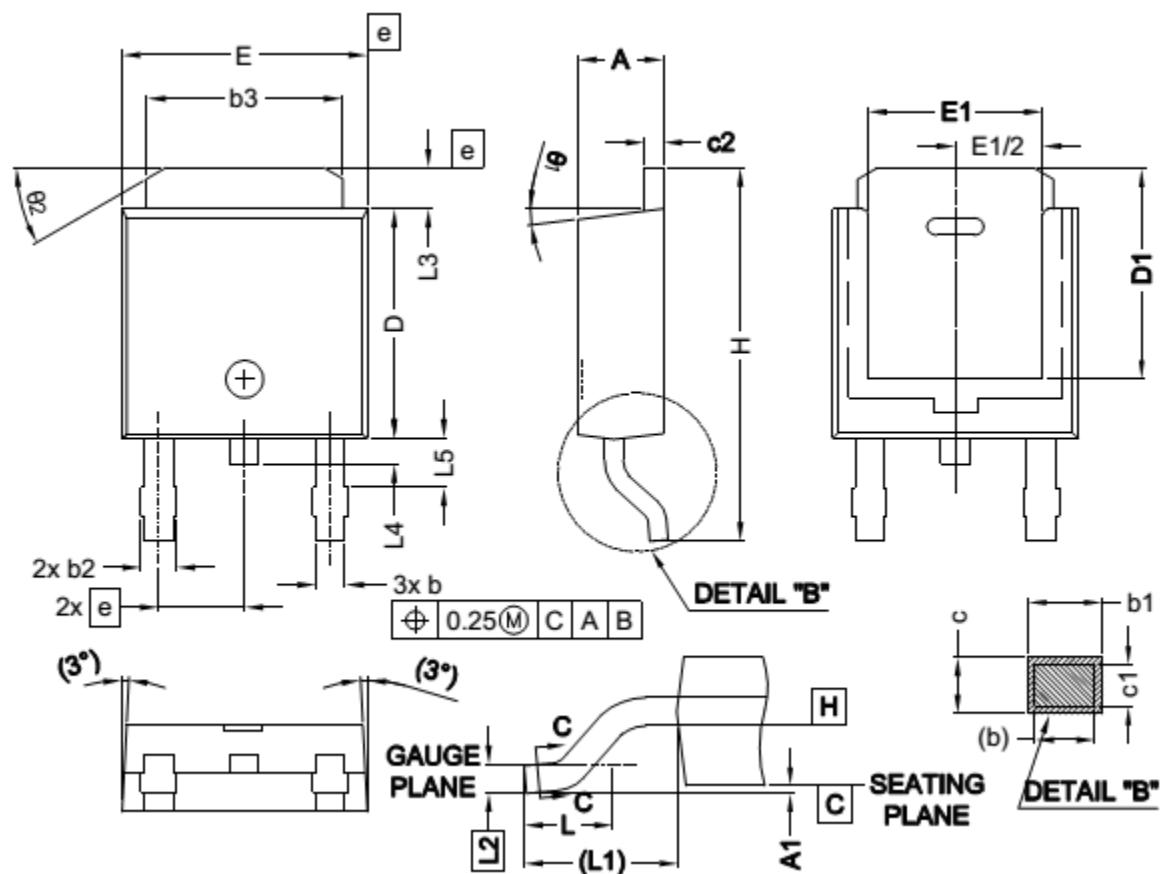
### I-PAK(TO-251) (h)



Symbol	Millimeters
A	6.40 ~ 6.60
A1	5.30 ~ 5.50
B	5.40 ~ 5.70
C	1.35 ~ 1.65
D	7.40 ~ 8.00
D1	0.60 ~ 0.75
D2	2.30
D3	0.49 ~ 0.59
D4	1.72 ~ 1.82
E	2.20 ~ 2.40
F	0.55 ~ 0.65
a1	5 deg
a2	5 deg
a3	2 deg

## Package Dimension

D-PAK(TO-252) (a)



SYMBOL	MIN.	MAX.	SYMBOL	MIN.	MAX.	SYMBOL	MIN.	MAX.
A	2.18	2.39	E	6.35	6.73	Ø1	0°	15°
A1	-	0.13	E1	4.32	-	Ø2	25°	35°
b	0.640	0.884	e	2.29	BSC			
b1	0.65	0.79	H	9.94	10.34			
b2	0.760	1.124	L	1.50	1.78			
b3	4.95	5.46	L1	2.74	REF			
c	0.46	0.61	L2	0.51	BSC			
c1	0.41	0.56	L3	0.89	1.27			
c2	0.40	0.60	L4	-	1.02			
D	5.97	6.22	L5	1.140	1.492			
D1	5.21	-	Ø	0°	10°			

**Package Dimension****D-PAK(TO-252) (Z)**